

Search Notes

Application/Control No.

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Examiner

John L. Goodrow

Applicant(s)/Patent under
Reexamination

JUNG, HEE-WON

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
430	109.2	3/20/2006	JG
	109.3		
	109.4		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor name search and east	3/20/2006	JG